Search Notes

| Application/Control No. | Applicant(s)/Patent under Reexamination |
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| 10/620 615 | KLOSE ET:AL |

10/629,615 Examiner

Dmitry Levitan

KLOSE ET AL. Art Unit

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| | SEARCHED | | | | | |
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| Class | Subclass | Date | Examiner | | | |
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| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | | | |
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